

PERFORMANCE AND TESTING OF THE COLUTA ADC ASIC

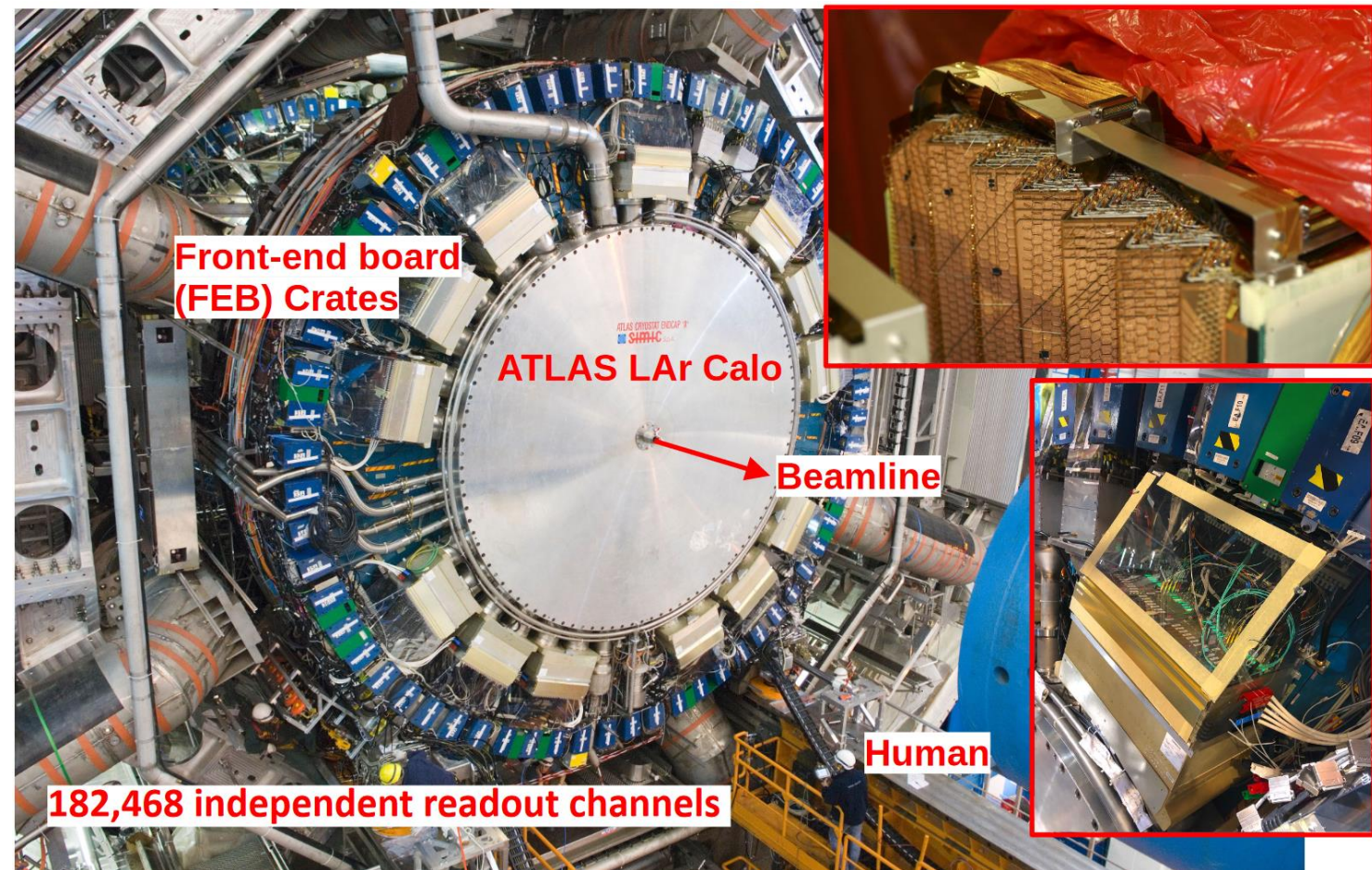
for the ATLAS HL-LHC Liquid Argon Calorimeter Readout

MICHAEL HIMMELSBACH

Research Engineer, The University of Texas at Austin

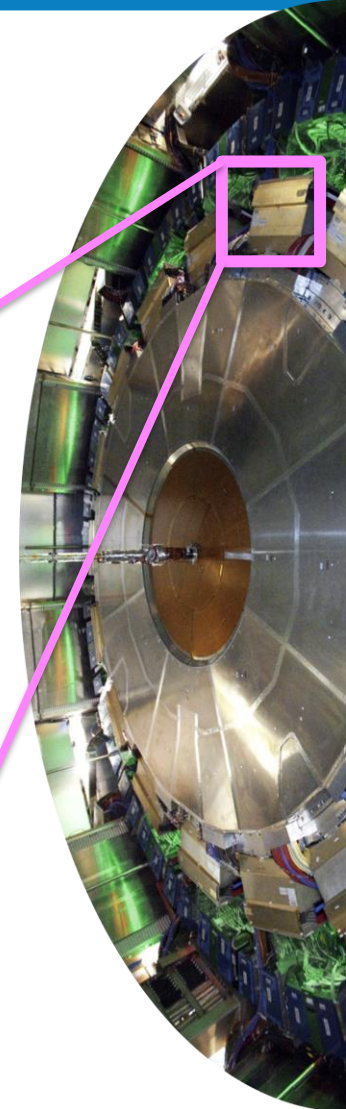
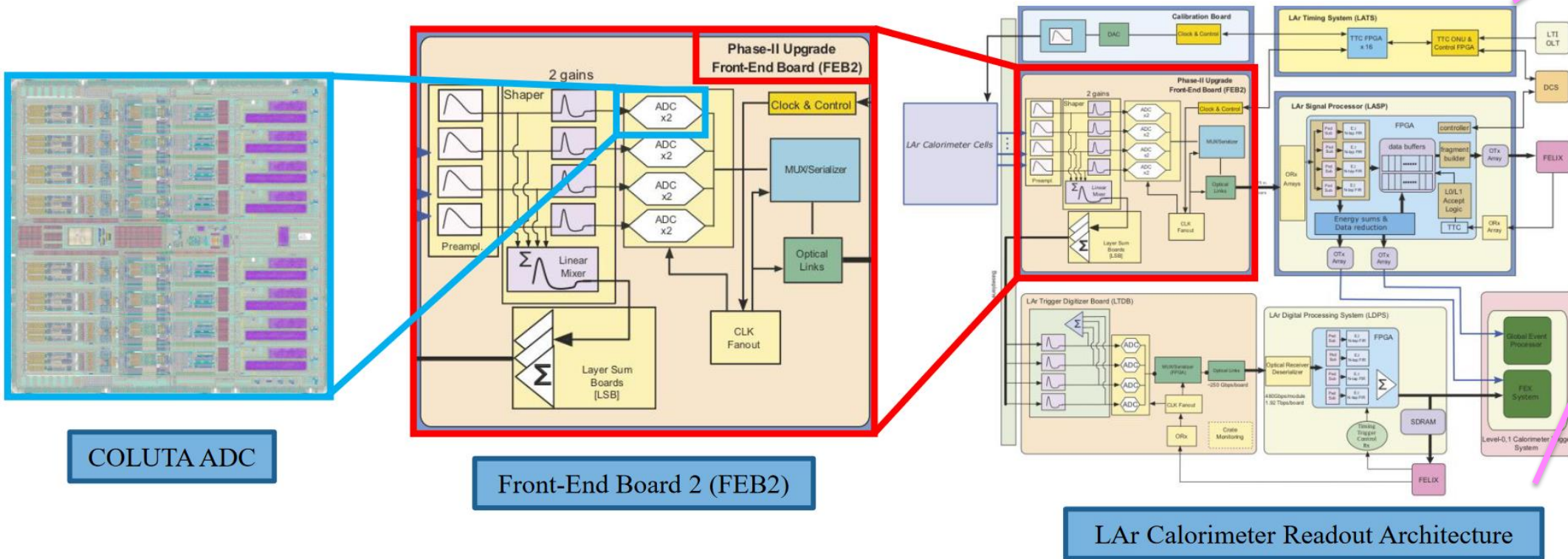


- **COLUTAv4 ADC**
 - ATLAS HL-LHC Upgrade
- *Verification of:*
 - Radiation hardness
 - Precision Performance
- *Preliminary production QC testing results*



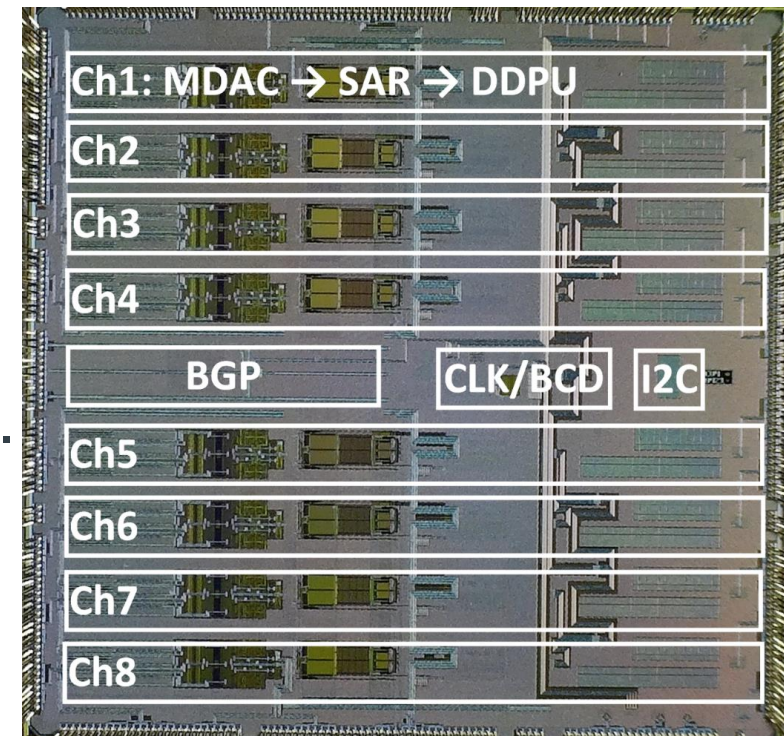
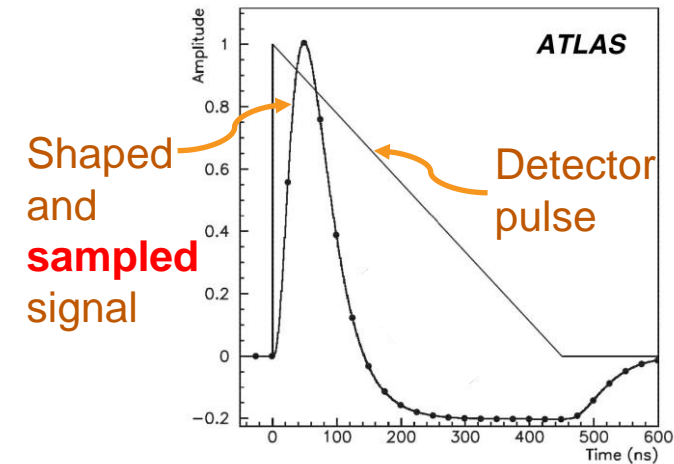
Upgrade: LAr Calorimeter Readout

- Readout of the ATLAS LAr calorimeter at the HL-LHC will be provided by 1524 on-detector Front-End Board boards.
 - ATLAS trigger HL-LHC requirement: ≤ 1 MHz L1 trigger rate, 10 μ S latency, radiation hardening.
- Original readout architecture cannot handle the full HL-LHC ATLAS trigger requirement.
- This talk will focus on the performance of the COLUTAv4 LAr ADC.



COLUTAv4 ADC Overview

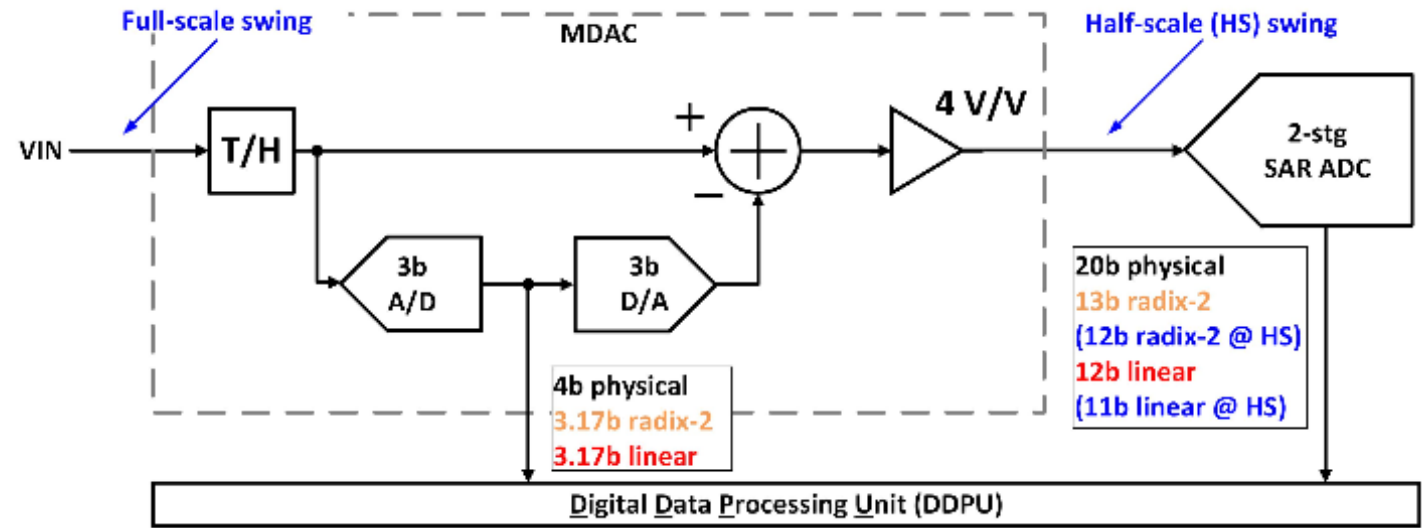
- Final prototype (4th iteration) of full custom COLUTA ADC ASIC.
- 8-channel, 15-bit, A/D converter.
 - 3.5-bit Multiplying DAC (MDAC) followed by 12-bit Successive Approximation Register (SAR).
 - Digital Data Processing Unit (DDPU) applies calibration bit weights and serially transmits data at 640 MBPS.
- Digitize at 40 MSPS.
- Fabricated in TSMC 65 nm CMOS.
 - 5.585 x 5.454 mm² chip die.
 - 4.3 million transistors.
 - 1.2V operation with 2 V_{pk-pk} differential inputs.
- ≥ 14 -bit dynamic range and > 11 -bit ENOB precision.
- Radiation tolerance design for HL-LHC.
- Packaged in Ball Grid Array.



COLUTAv4 ADC Design

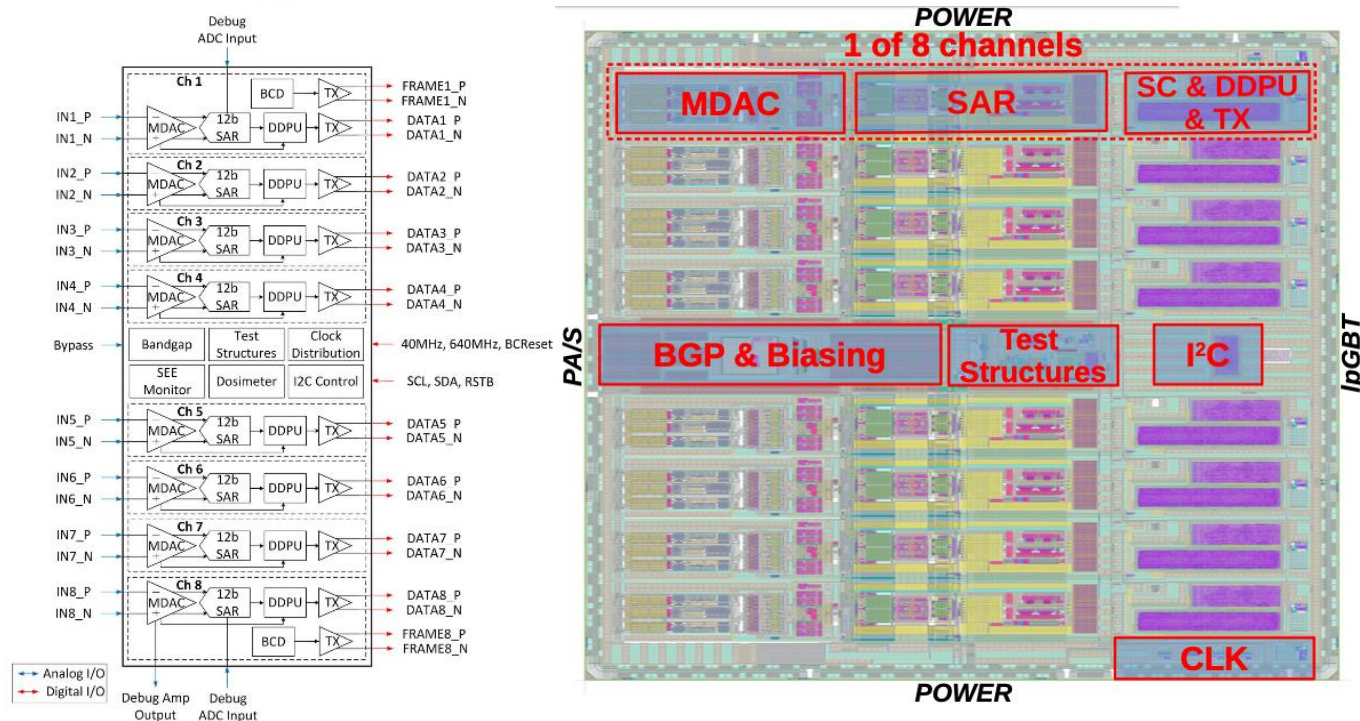
- Single channel architecture

- 3.5-bit Multiplying DAC (MDAC) followed by 12-bit Successive Approximation Register (SAR).
- ENOB and dynamic range specifications are met by using an MDAC to “extend” the dynamic range of a SAR ADC to 15-bits.



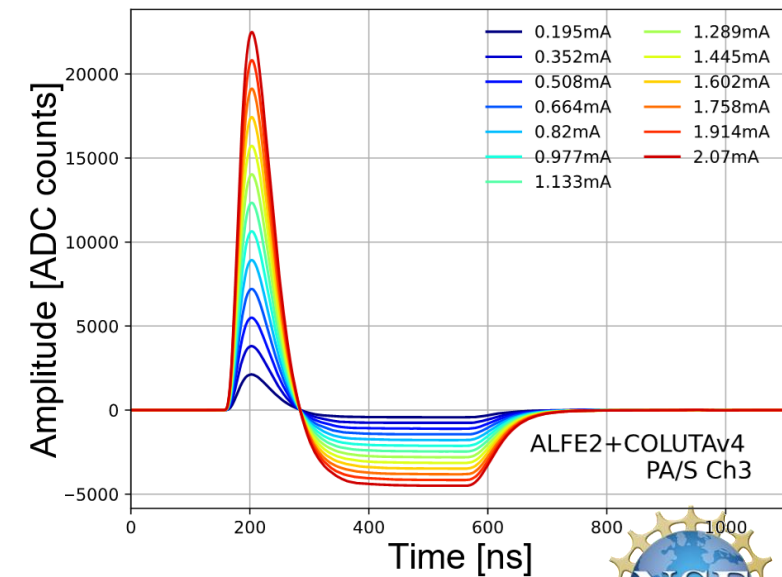
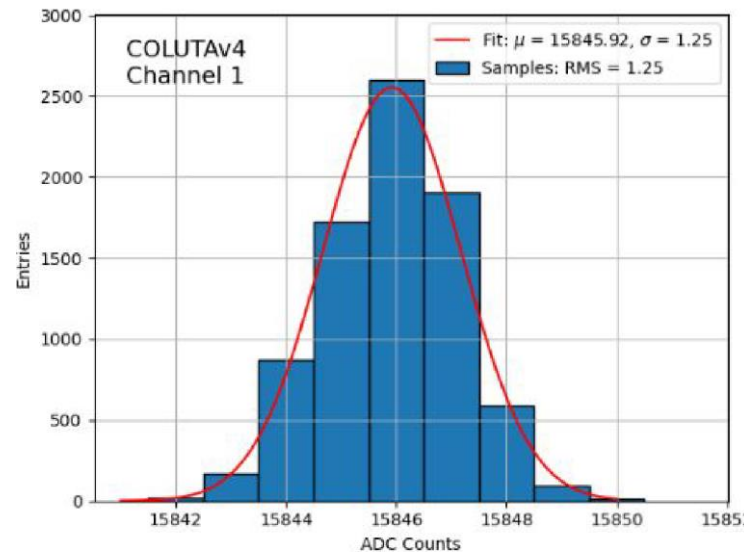
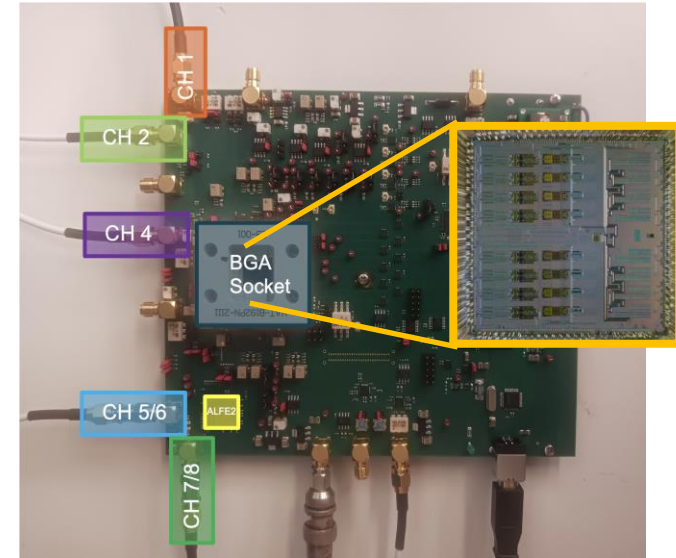
- Chip architecture

- Eight independent and identical channels implemented.
- Seamless interface between PA/S and IpGBT.
- On-chip calibration circuit for MDAC and SAR



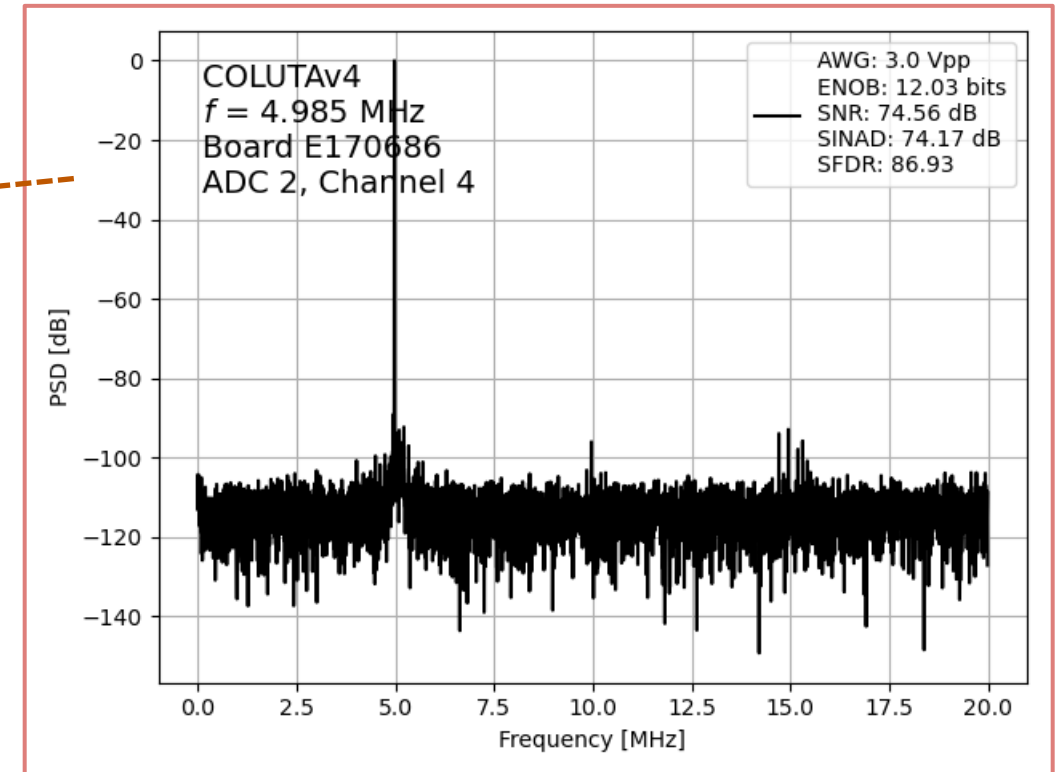
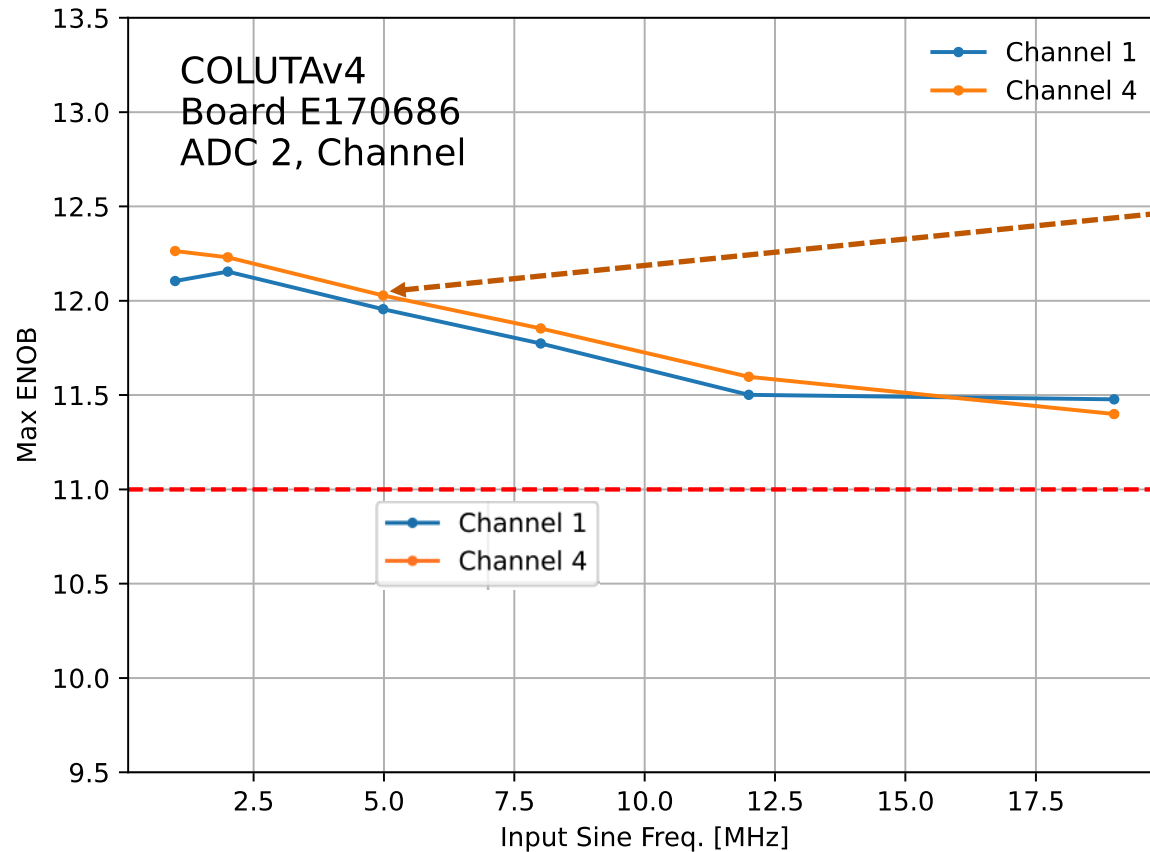
Precision Measurement Setup

- Socketed board used for QA/QC; soldered test boards used for precision analog tests.
 - Ch1,4: passive transformer input.
 - Ch2: commercial amplifier input.
 - Ch3: 16-bit DAC input.
 - Ch5,6,7,8: Pre-amp shaper (ALFE2) input.
- Feature-less pedestal; ~ 1.2 ADC counts RMS of noise out of 2^{15} .
 - CV4 meets dynamic range spec (*c.f.* ≥ 14 bits)
- For large pulses, achieve an energy resolution $\sigma(E)/E < 0.25\%$ and a time resolution < 100 ps



Performance - Sine Wave Sweeps

- Sine wave sweeps across amplitude and frequency show well-behaved performance exceeding specifications.



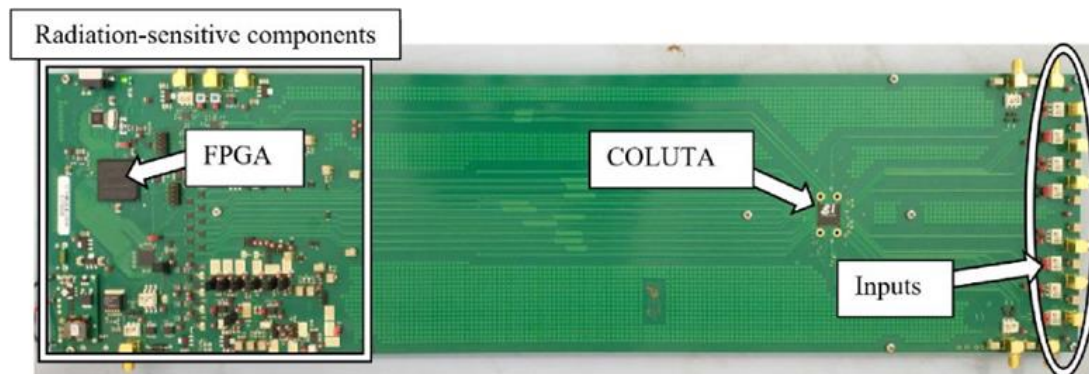
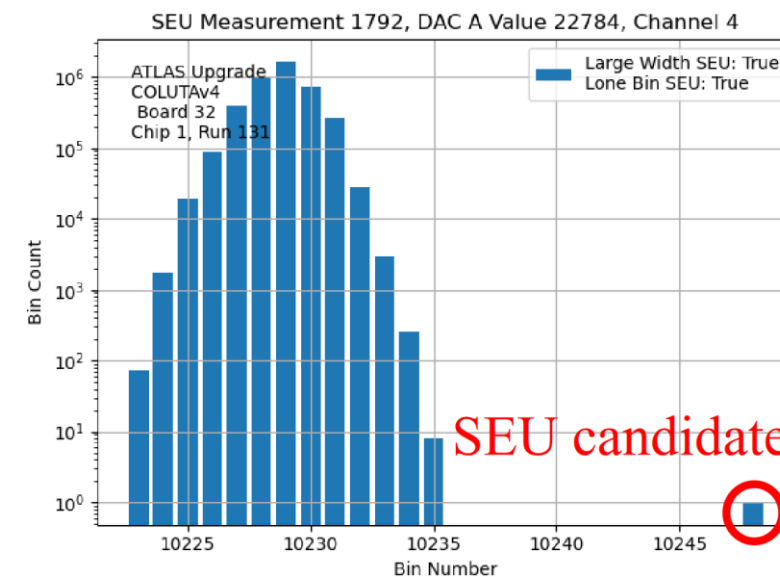
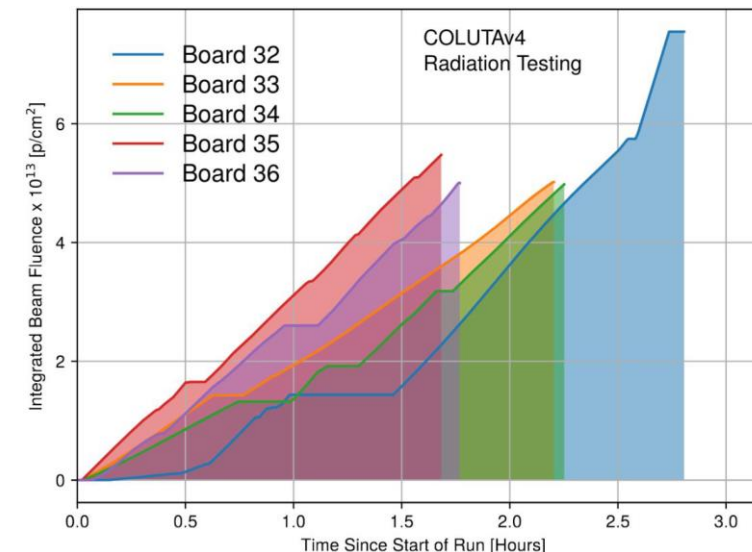
Radiation Hardness Verification

- All on-detector electronics must meet radiation hardness requirements:

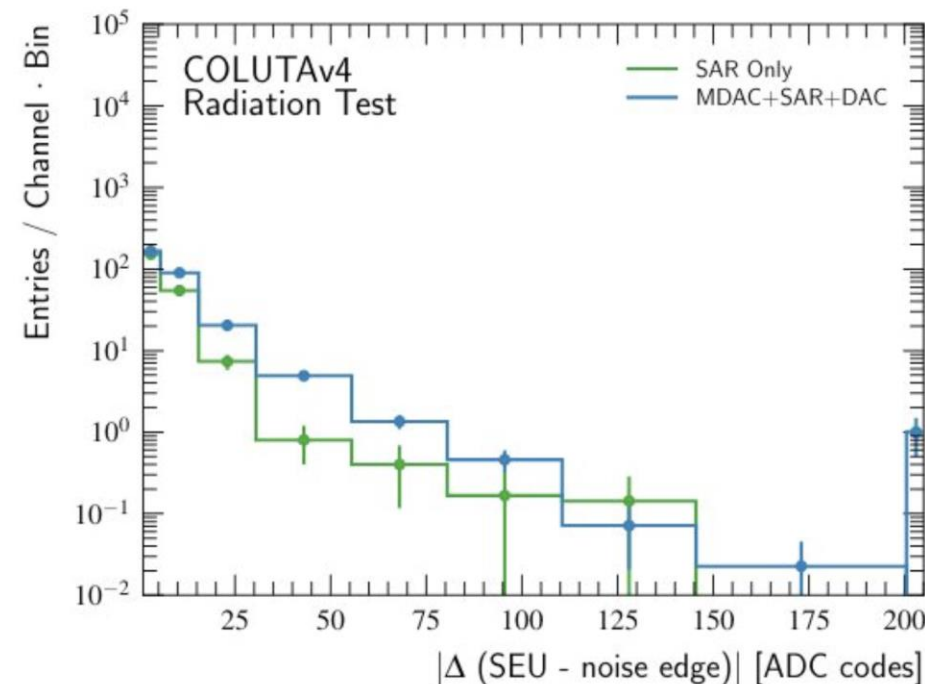
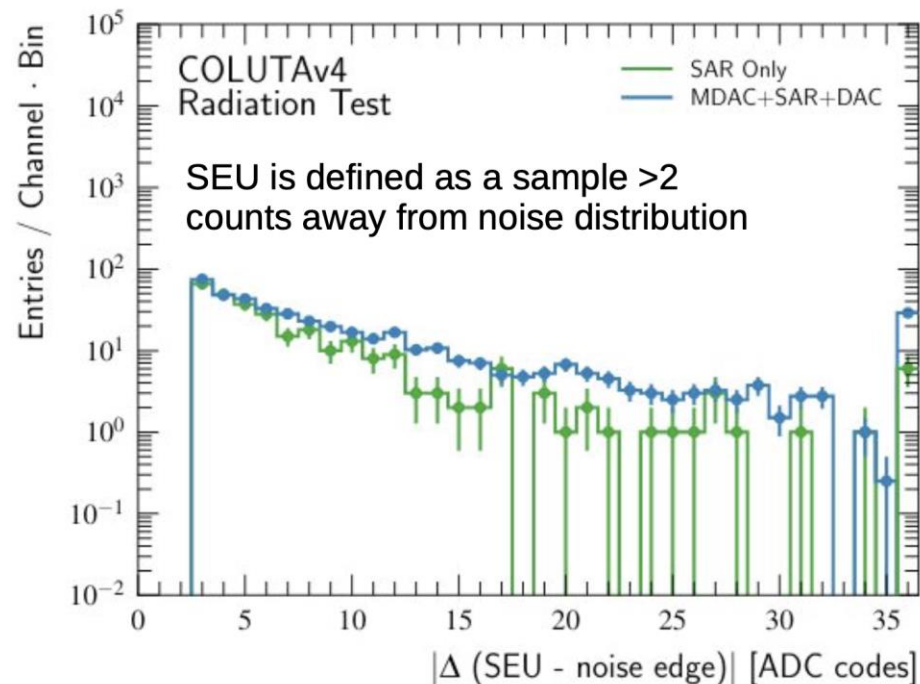
TID [Gy]	NIEL [n_{eq}/cm^2]	SEE [$h_{>20 MeV}/cm^2$]
1400 (1.5)	4.1×10^{13} (2)	1.0×10^{13} (3)

- Radiation test of COLUTAv4

- Carried out on Aug. 6 & 7th 2022 at Boston Massachusetts General Hospital using 229 MeV proton beam.
 - Additional test (BGA packaged chips) planned.
- 5 chips irradiated beyond spec ($\sim 5 \times 10^{13}$ p/cm²) with no chip latch-ups.
- Elongated test board with 8-ch passive inputs:

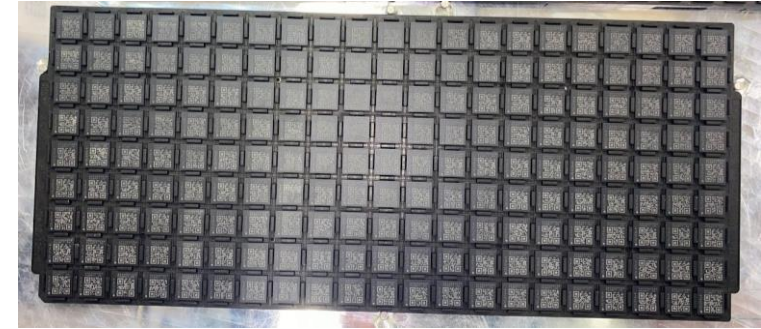


- SEU's near the noise distribution are probably “analog” errors.
 - *E.g.* ionizing particle disturbing charge in the sample/hold capacitors.
- SEU's far from the noise distribution are probably “digital” errors.
 - *E.g.* ionizing particle flipping a bit.



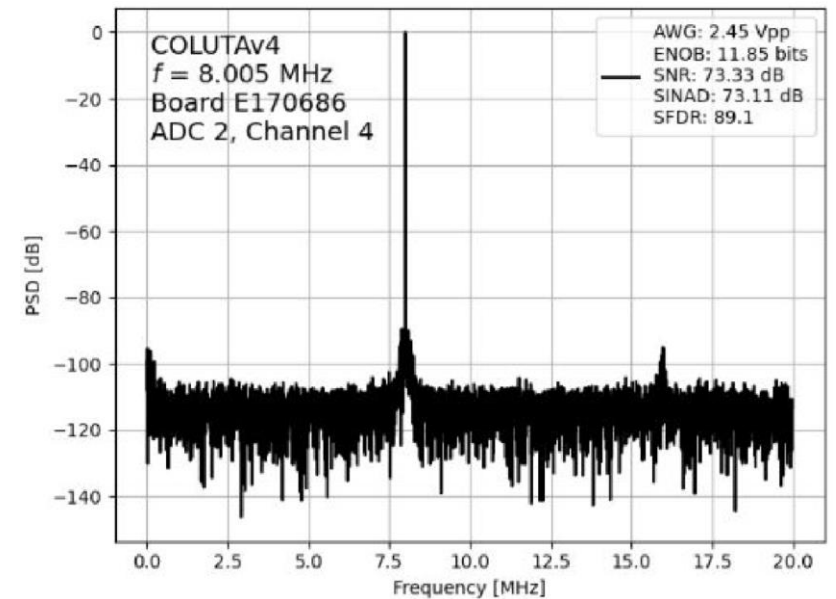
- **Over the course of the HL-LHC, we expect a total of 6140 SEU's per channel. 75% will be within 20 ADC counts of the correct code; less than 1% will be greater than 100 counts away.**

- Required on detector (plus spares): ~ 60k COLUTA chips. **Automated testing required!**
 - Two test sites planned
- Automated Robotic Tester for Mass Inspections of COLUTA ASIC (ARTEMICA).
 - Pre-production engineering run ASIC under test now.
- Robot arm functionalities:
 - Read and decode ASIC QR code.
 - Pick chip from tray and place the chip in the socket.
 - Remove chip from the socket and place it back on the tray.
 - Move chips between trays.
- Robot control and operation integrated with data acquisition software.
 - GUI can control the robot arm, power supply, signal generators.
- Automated test procedure:
 1. Move the robot arm over a chip and decode the QR code to obtain chip ID.
 2. Socket the chip.
 3. Perform a “dead-or-alive” test to ensure chip is functional.
 4. Perform a “performance” test and classify the chip-performance.
 5. Based on its performance, sort the chip-under-test into the graded-chips tray.
 6. Repeat

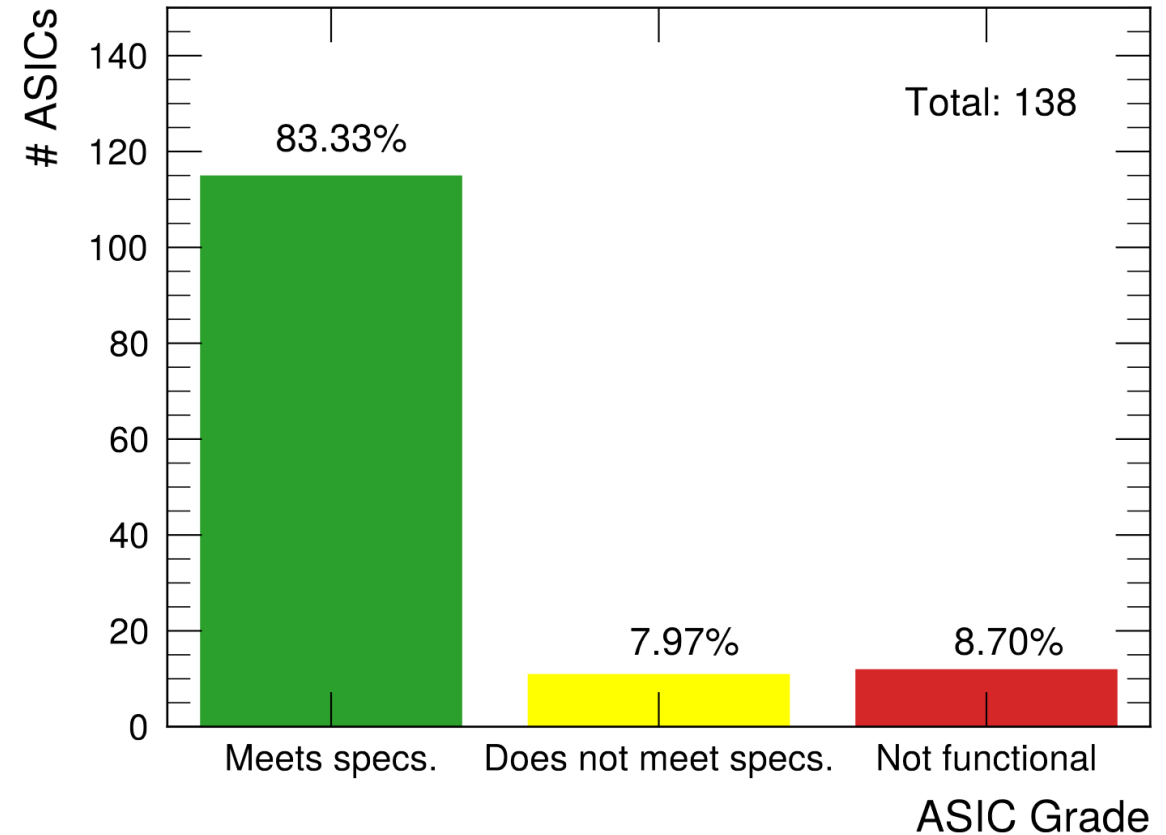
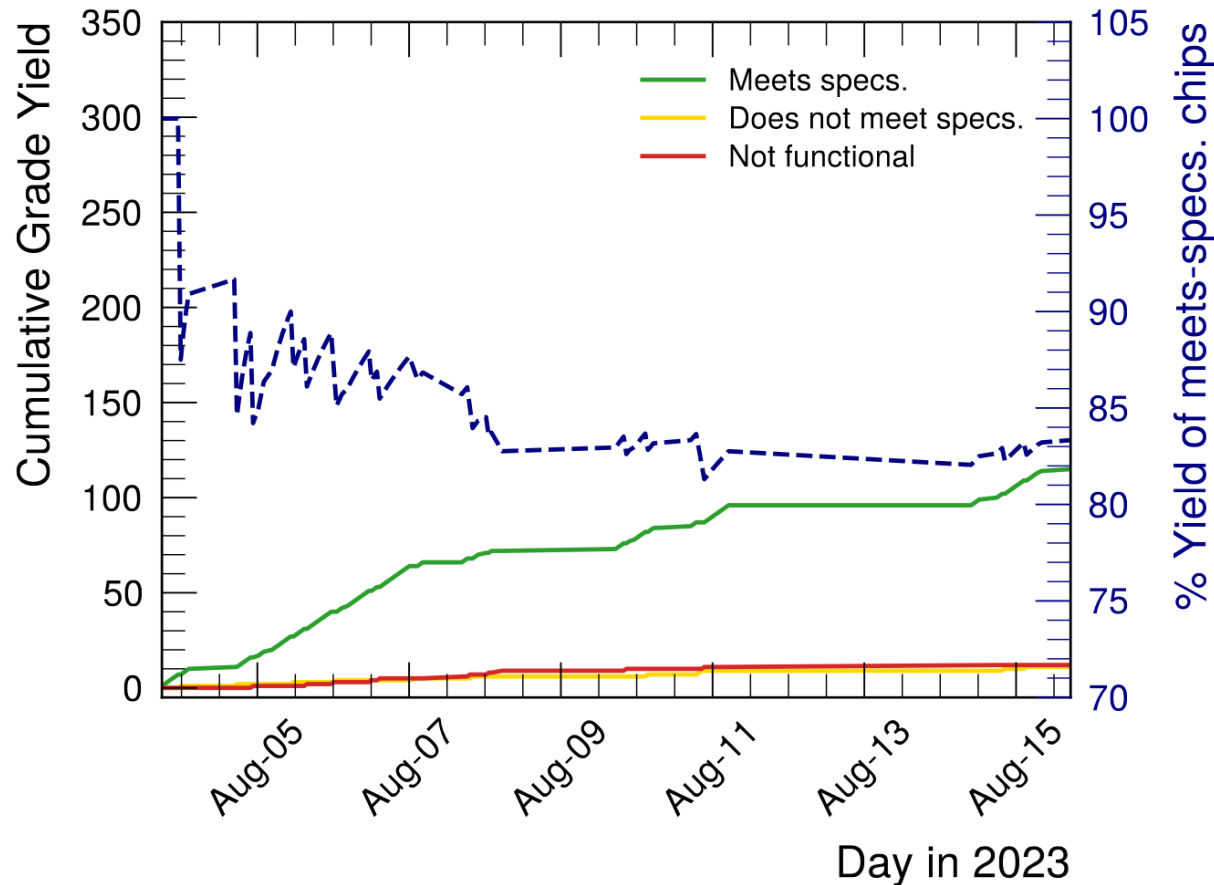


- Perform two set of tests on the chip-under-test:
 - Dead-or-Alive test to measure chip health.
 - Performance test to calibrate the channels and measure chip performance.
 - Chip is discarded if dead-or-alive test fails
 - All chips tested so far are functional, no “dead” chips observed yet.
- Chips sorted into three categories:
 - Functional & meets specs.
 - Functional & does not meet specs.
 - Not functional.
- Sine-wave performance with $f_{\text{sine}} = 8\text{MHz}$ and amplitude near ADC full scale.
 - Minimum ENOB grade is used to decide the chip grade.

Chip Quality	min(Ch. 1, Ch. 4) ENOB [transformer_enob]	Ch. 2 ENOB [amplifier_enob]
Functional & meets specs.	≥ 11.5 [11.0, 11.5)	≥ 10.5 [10.0, 10.5)
Functional, does not meet specs.	[10.5, 11.0) [10.0, 10.5)	[9.8, 10.0) [9.6, 9.8)
Not functional	≤ 10.0	≤ 9.6

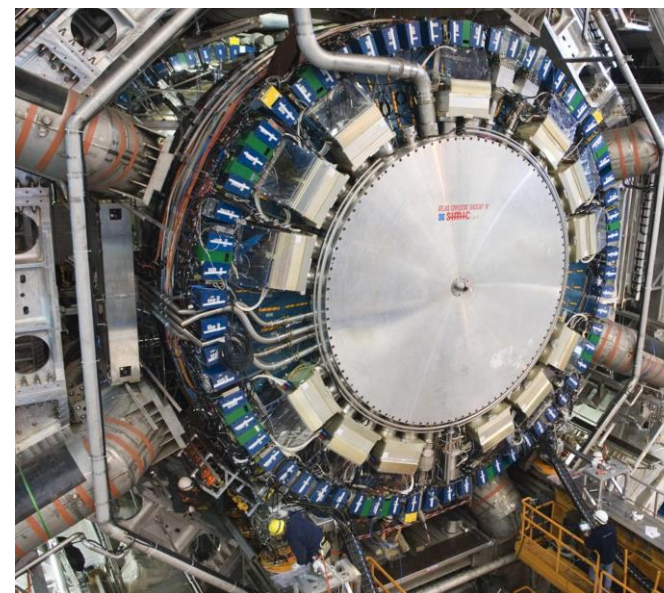
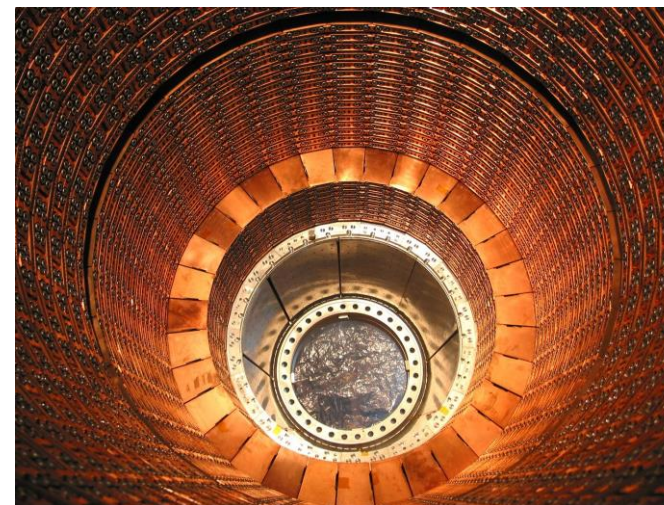


Mass testing with preproduction (engineering run) ASICs



Developing new testboard with identical inputs to measure uniformly the channel performance.

- The LAr calorimeter is vital to the success of the physics program at ATLAS in the HL-LHC.
 - Current LAr readout does not meet HL-LHC trigger requirements, nor will it survive full HL-LHC radiation dose.
 - All LAr electronics (on- and off-detector) will be replaced by **2029** for HL-LHC operation (except cold preamp/summing in HEC).
 - Designed to run through **2041**.
- Major progress on COLUTA ADC for LAr HL-LHC upgrade.
 - Full custom LAr-specific ADC ASIC in pre-production. Meet specifications for analog performance.
 - Preparing for mass testing of 60,000 chips required on detector.
- On schedule for installation into ATLAS cavern beginning in **2026**, after the end of LHC Run 3.

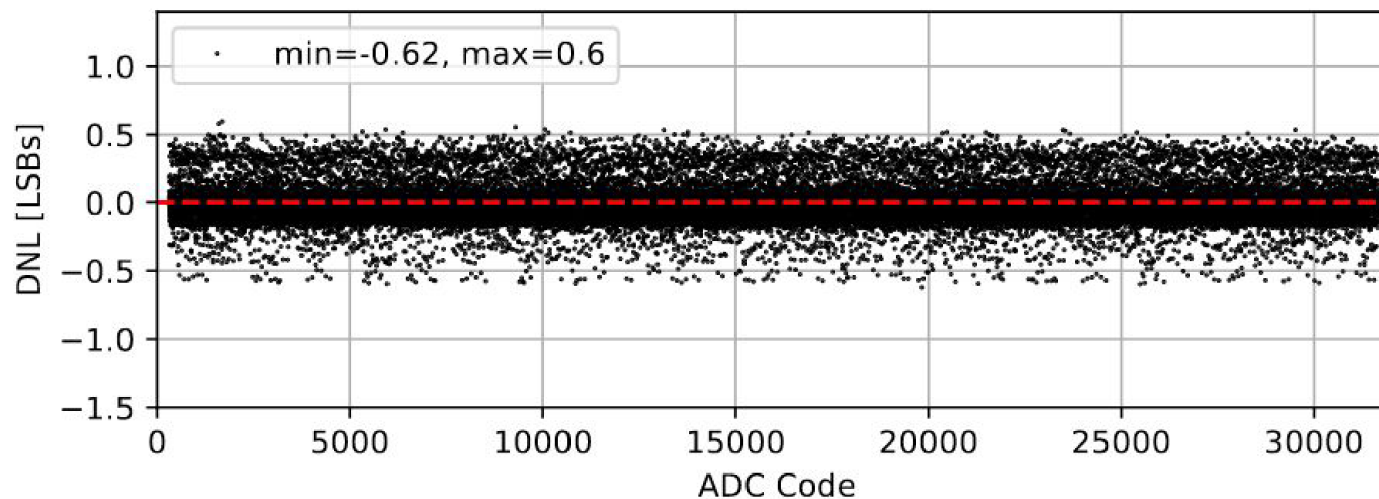


Backup

Performance – INL/DNL

Slow sine wave/histogramming used to test DNL; linear DAC ramp used to test INL;

$$DNL_j = \frac{V_{j+1} - V_j}{1 \text{ LSB}} - 1$$



$$INL_j = \frac{V_j - V_{fit,j}}{1 \text{ LSB}}$$

